

Click to view price, real time Inventory,  
Delivery & Lifecycle Information ;

# CSD13381F4T

Texas instruments

MOSFET 12V,N-Ch FemtoFET MOSFET

Any questions,please feel free to contact us.  
[info@kaimte.com](mailto:info@kaimte.com)

# CSD13381F4 12-V N-Channel FemtoFET™ MOSFET

## 1 Features

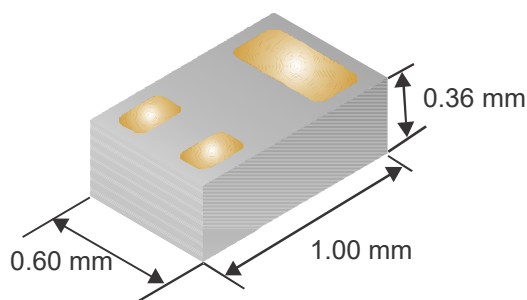
- Low on-resistance
- Low  $Q_g$  and  $Q_{gd}$
- Low threshold voltage
- Ultra-small footprint (0402 case size)
  - 1.0 mm × 0.6 mm
- Ultra-low profile
  - Maximum height: 0.36-mm
- Integrated ESD protection diode
  - Rated > 4-kV HBM
  - Rated > 2-kV CDM
- Lead and halogen free
- RoHS compliant

## 2 Applications

- Optimized for load switch applications
- Optimized for general purpose switching applications
- Single-cell battery applications
- Handheld and mobile applications

## 3 Description

This 140-m $\Omega$ , 12-V N-channel FemtoFET™ MOSFET technology is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing at least a 60% reduction in footprint size.



**Typical Device Dimensions**

## Product Summary

$T_A = 25^\circ\text{C}$		TYPICAL VALUE	UNIT
$V_{DS}$	Drain-to-source voltage	12	V
$Q_g$	Gate charge total (4.5 V)	1060	pC
$Q_{gd}$	Gate charge gate-to-drain	140	pC
$R_{DS(on)}$	Drain-to-source on-resistance	$V_{GS} = 1.8\text{ V}$	310 m $\Omega$
		$V_{GS} = 2.5\text{ V}$	170 m $\Omega$
		$V_{GS} = 4.5\text{ V}$	140 m $\Omega$
$V_{GS(th)}$	Threshold voltage	0.85	V

## Ordering Information

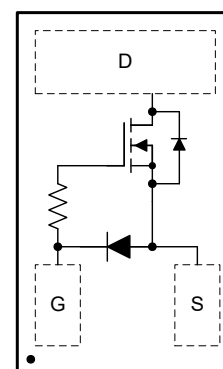
DEVICE <sup>(1)</sup>	QTY	MEDIA	PACKAGE	SHIP
CSD13381F4	3000	7-inch reel	Femto (0402) 1.0-mm × 0.6-mm SMD lead less	Tape and reel
CSD13381F4T	250			

- (1) For all available packages, see the orderable addendum at the end of the data sheet.

## Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$ unless otherwise stated		VALUE	UNIT
$V_{DS}$	Drain-to-source voltage	12	V
$V_{GS}$	Gate-to-source voltage	8	V
$I_D$	Continuous drain current, $T_A = 25^\circ\text{C}$ <sup>(1)</sup>	2.1	A
$I_{DM}$	Pulsed drain current, $T_A = 25^\circ\text{C}$ <sup>(2)</sup>	7	A
$I_G$	Continuous gate clamp current	35	mA
	Pulsed gate clamp current <sup>(2)</sup>	350	
$P_D$	Power dissipation <sup>(1)</sup>	500	mW
ESD Rating	Human body model (HBM)	4	kV
	Charged device model (CDM)	2	kV
$T_J$ , $T_{stg}$	Operating junction and storage temperature range	–55 to 150	$^\circ\text{C}$
$E_{AS}$	Avalanche energy, single pulse $I_D = 7.4\text{ A}$ , $L = 0.1\text{ mH}$ , $R_G = 25\text{ }\Omega$	2.7	mJ

- (1) Typical  $R_{\theta JA} = 90^\circ\text{C/W}$  on 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>), 2 oz. (0.071 mm thick) Cu pad on a 0.06 inch (1.52 mm) thick FR4 PCB.
- (2) Pulse duration  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$



**Top View**



## Table of Contents

<b>1 Features</b> .....	<b>1</b>	6.1 Trademarks.....	<b>7</b>
<b>2 Applications</b> .....	<b>1</b>	6.2 Electrostatic Discharge Caution.....	<b>7</b>
<b>3 Description</b> .....	<b>1</b>	6.3 Glossary.....	<b>7</b>
<b>4 Revision History</b> .....	<b>2</b>	<b>7 Mechanical, Packaging, and Orderable Information</b> ....	<b>8</b>
<b>5 Specifications</b> .....	<b>3</b>	7.1 Mechanical Dimensions.....	<b>8</b>
5.1 Electrical Characteristics.....	<b>3</b>	7.2 Recommended Minimum PCB Layout.....	<b>9</b>
5.2 Thermal Information.....	<b>3</b>	7.3 Recommended Stencil Pattern.....	<b>9</b>
5.3 Typical MOSFET Characteristics.....	<b>4</b>	7.4 CSD13381F4 Embossed Carrier Tape Dimensions..	<b>10</b>
<b>6 Device and Documentation Support</b> .....	<b>7</b>		

## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

<b>Changes from Revision E (October 2021) to Revision F (January 2022)</b>	<b>Page</b>
• Changed Maximum height from "0.35 mm" to "0.36 mm" in <i>Features</i> .....	<b>1</b>
• Changed package height from "0.35 mm" to "0.36 mm" in <i>Typical Device Dimensions</i> .....	<b>1</b>
• Changed package height from "0.35 mm" to "0.36 mm" in <i>Mechanical Dimensions</i> .....	<b>8</b>

<b>Changes from Revision D (May 2015) to Revision E (October 2021)</b>	<b>Page</b>
• Added footnote with link to support document.....	<b>9</b>

<b>Changes from Revision C (September 2014) to Revision D (May 2015)</b>	<b>Page</b>
• Corrected typo for $I_{GSS}$ Test Condition .....	<b>3</b>

## 5 Specifications

### 5.1 Electrical Characteristics

(T<sub>A</sub> = 25°C unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
STATIC CHARACTERISTICS							
BV <sub>DSS</sub>	Drain-to-Source Voltage	V <sub>GS</sub> = 0 V, I <sub>DS</sub> = 250 μA	12			V	
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 9.6 V	100			nA	
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 8 V	50			nA	
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>DS</sub> = 250 μA	0.65	0.85	1.10	V	
R <sub>DS(on)</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> = 1.8 V, I <sub>DS</sub> = 0.5 A	310			400	mΩ
		V <sub>GS</sub> = 2.5 V, I <sub>DS</sub> = 0.5 A	170			225	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>DS</sub> = 0.5 A	140			180	mΩ
g <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 6 V, I <sub>DS</sub> = 0.5 A	3.2			S	
DYNAMIC CHARACTERISTICS							
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 6 V, f = 1 MHz	155			200	pF
C <sub>oss</sub>	Output Capacitance		47			62	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		2.5			3.3	pF
R <sub>G</sub>	Series Gate Resistance		23				Ω
Q <sub>g</sub>	Gate Charge Total (4.5 V)	V <sub>DS</sub> = 6 V, I <sub>DS</sub> = 0.5 A	1060			1400	pC
Q <sub>gd</sub>	Gate Charge Gate-to-Drain		140				pC
Q <sub>gs</sub>	Gate Charge Gate-to-Source		230				pC
Q <sub>g(th)</sub>	Gate Charge at V <sub>th</sub>		155				pC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 6 V, V <sub>GS</sub> = 0 V	1120				pC
t <sub>d(on)</sub>	Turn On Delay Time	V <sub>DS</sub> = 6 V, V <sub>GS</sub> = 4.5 V, I <sub>DS</sub> = 0.5 A, R <sub>G</sub> = 2 Ω	3.7				ns
t <sub>r</sub>	Rise Time		1.5				ns
t <sub>d(off)</sub>	Turn Off Delay Time		11.0				ns
t <sub>f</sub>	Fall Time		3.8				ns
DIODE CHARACTERISTICS							
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 0.5 A, V <sub>GS</sub> = 0 V	0.73			0.9	V
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DS</sub> = 6 V, I <sub>F</sub> = 0.5 A, di/dt = 300 A/μs	1550				pC
t <sub>rr</sub>	Reverse Recovery Time		6				ns

### 5.2 Thermal Information

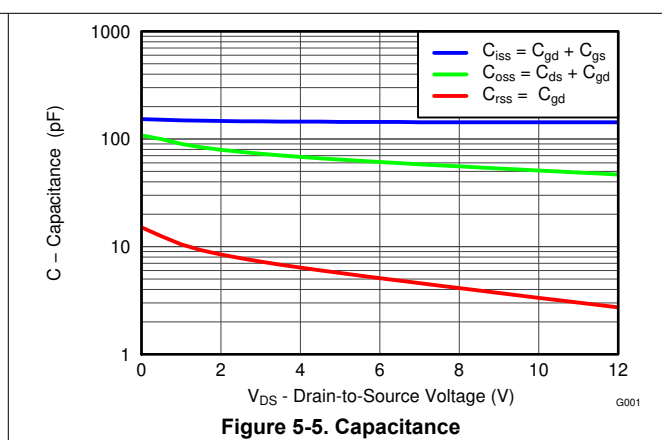
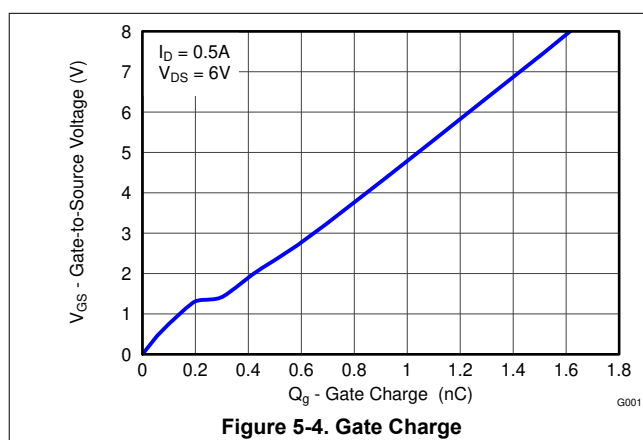
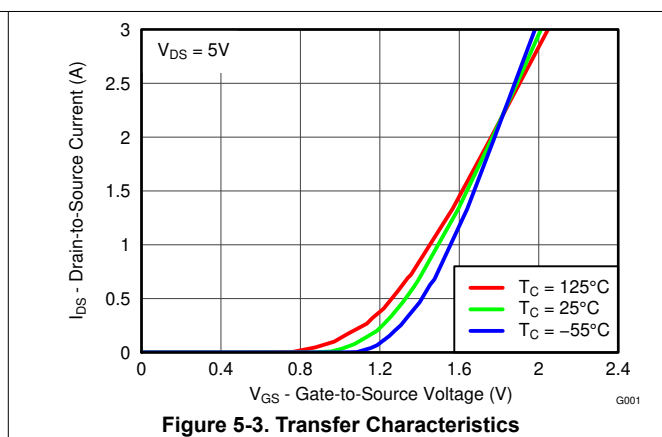
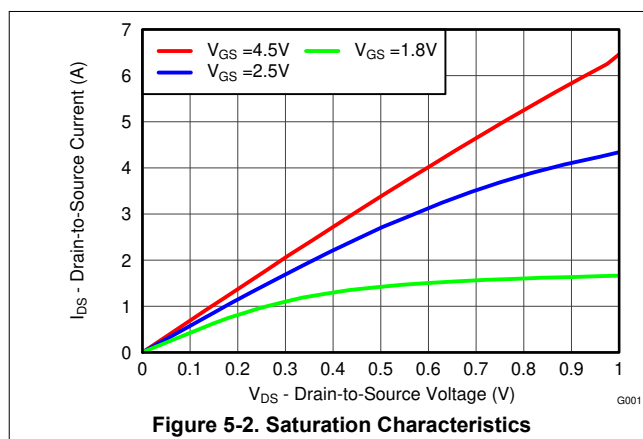
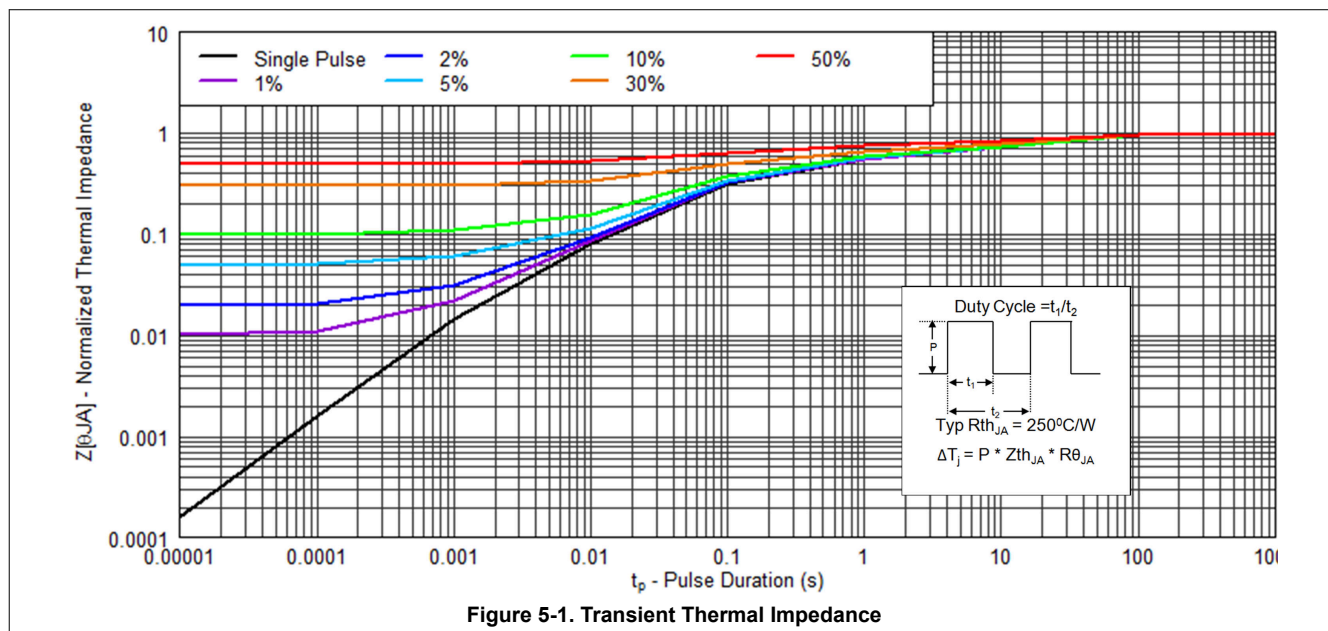
(T<sub>A</sub> = 25°C unless otherwise stated)

THERMAL METRIC		TYPICAL VALUES	UNIT
R <sub>θJA</sub>	Junction-to-Ambient Thermal Resistance <sup>(1)</sup>	90	°C/W
	Junction-to-Ambient Thermal Resistance <sup>(2)</sup>	250	

- (1) Device mounted on FR4 material with 1 inch<sup>2</sup> (6.45 cm<sup>2</sup>), 2 oz. (0.071 mm thick) Cu.  
 (2) Device mounted on FR4 material with minimum Cu mounting area.

## 5.3 Typical MOSFET Characteristics

( $T_A = 25^\circ\text{C}$  unless otherwise stated)



### 5.3 Typical MOSFET Characteristics (continued)

( $T_A = 25^\circ\text{C}$  unless otherwise stated)

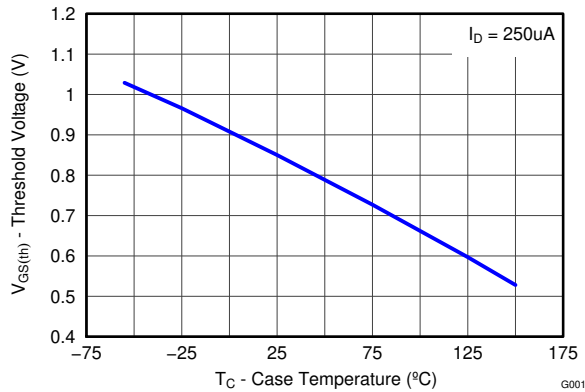


Figure 5-6. Threshold Voltage vs Temperature

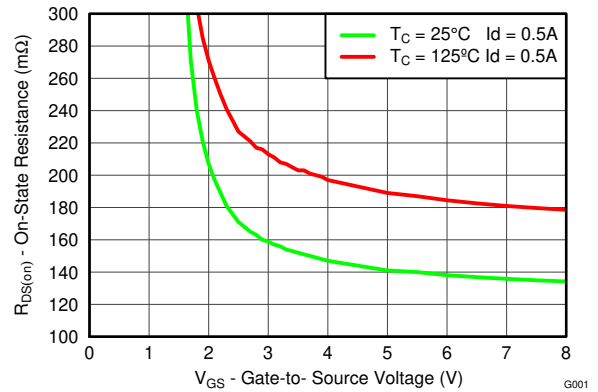


Figure 5-7. On-State Resistance vs Gate-to-Source Voltage

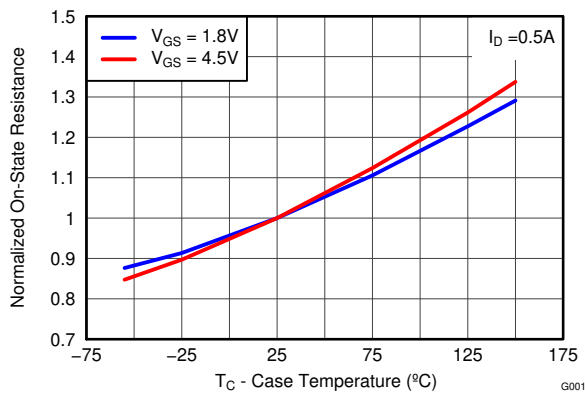


Figure 5-8. Normalized On-State Resistance vs Temperature

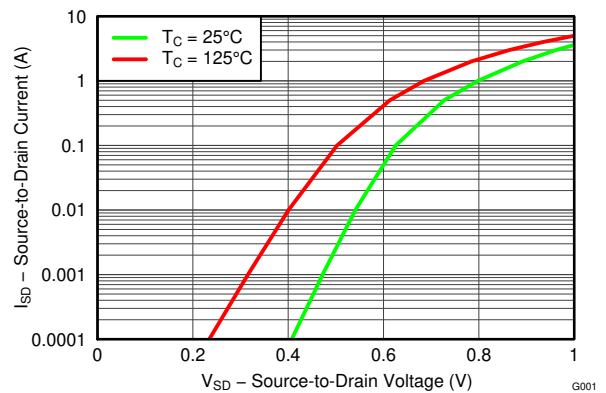


Figure 5-9. Typical Diode Forward Voltage

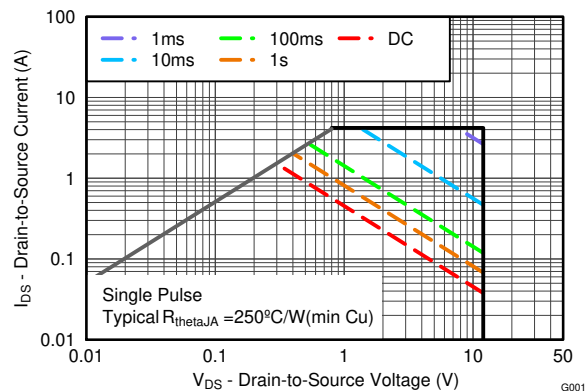


Figure 5-10. Maximum Safe Operating Area (SOA)

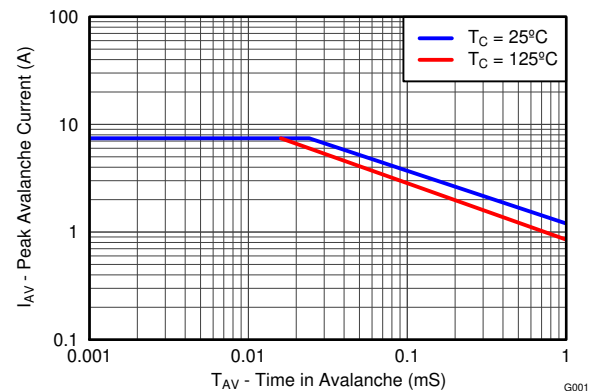


Figure 5-11. Single Pulse Unclamped Inductive Switching

### 5.3 Typical MOSFET Characteristics (continued)

( $T_A = 25^\circ\text{C}$  unless otherwise stated)

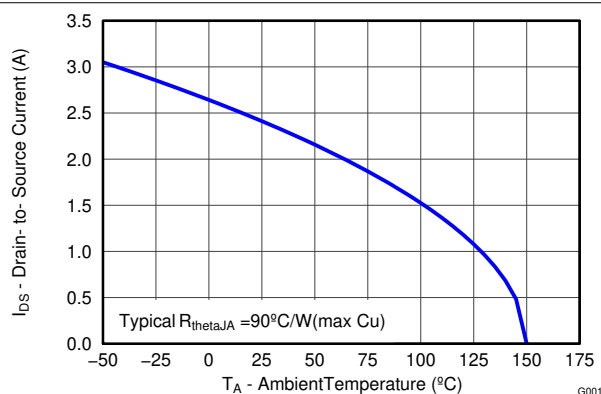


Figure 5-12. Maximum Drain Current vs Temperature

## 6 Device and Documentation Support

### 6.1 Trademarks

FemtoFET™ is a trademark of Texas Instruments.  
is a trademark of Texas Instruments.  
All trademarks are the property of their respective owners.

### 6.2 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 6.3 Glossary

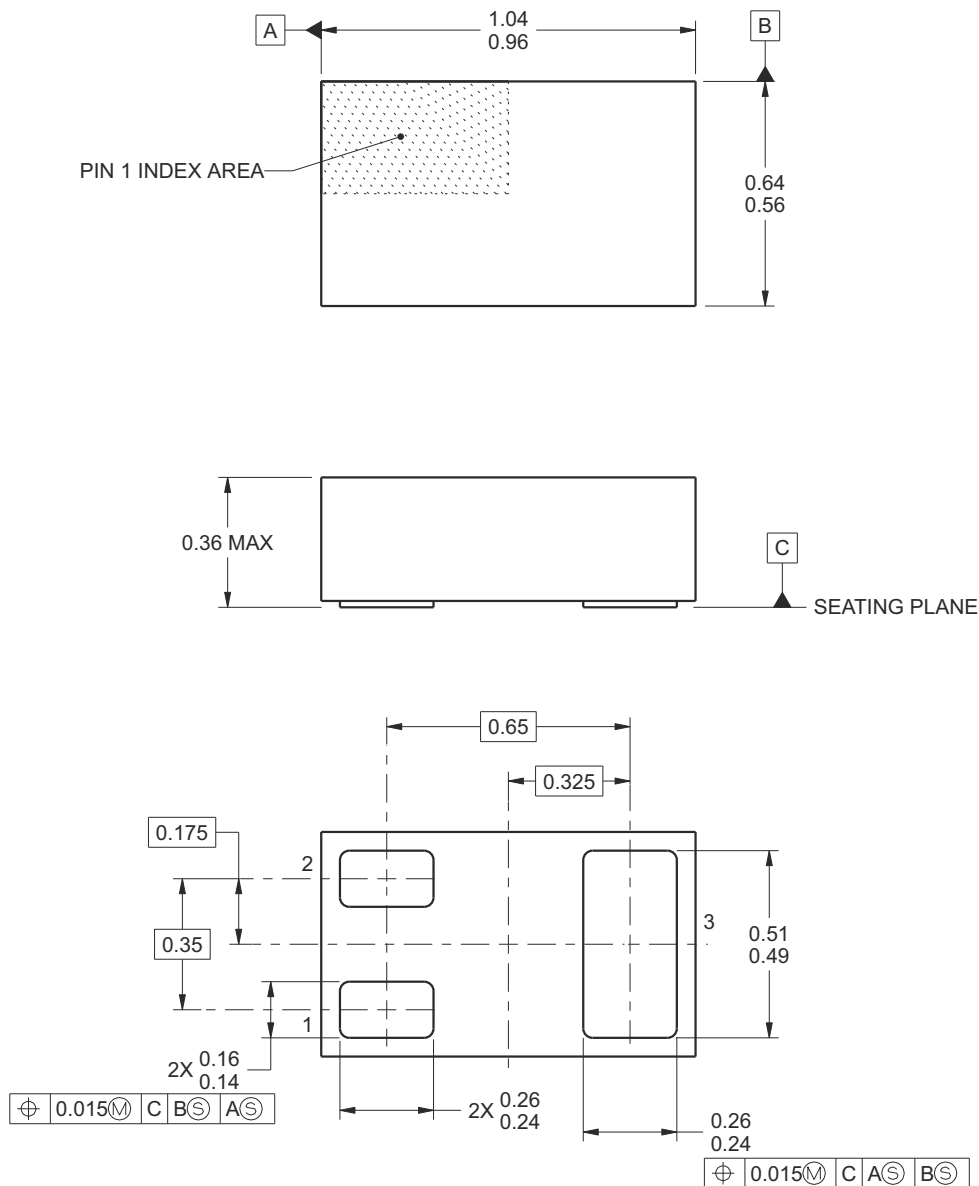
[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.



## 7 Mechanical, Packaging, and Orderable Information

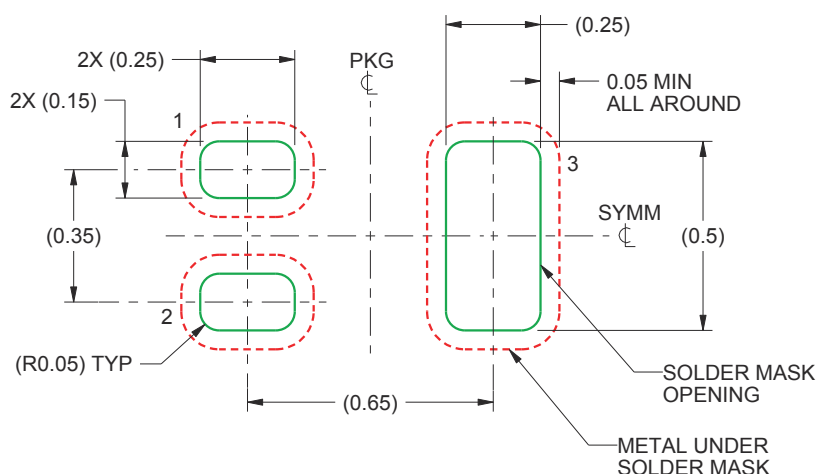
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

### 7.1 Mechanical Dimensions



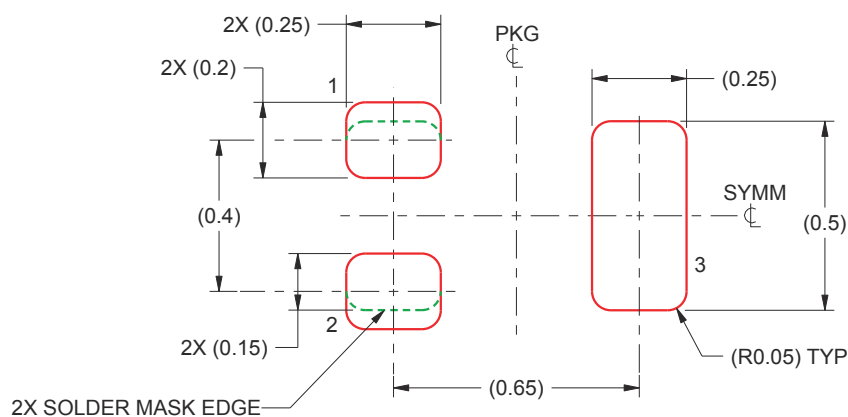
- A. All linear dimensions are in millimeters (dimensions and tolerancing per AME T14.5M-1994).
- B. This drawing is subject to change without notice.
- C. This package is a PB-free solder land design.

## 7.2 Recommended Minimum PCB Layout



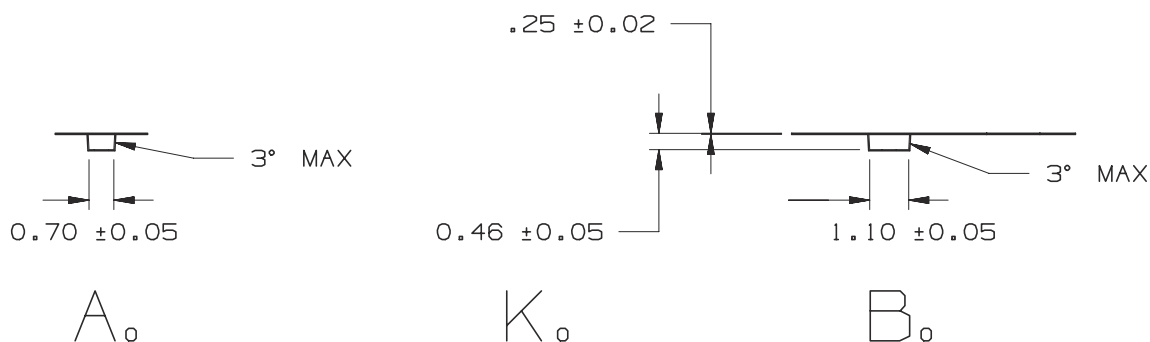
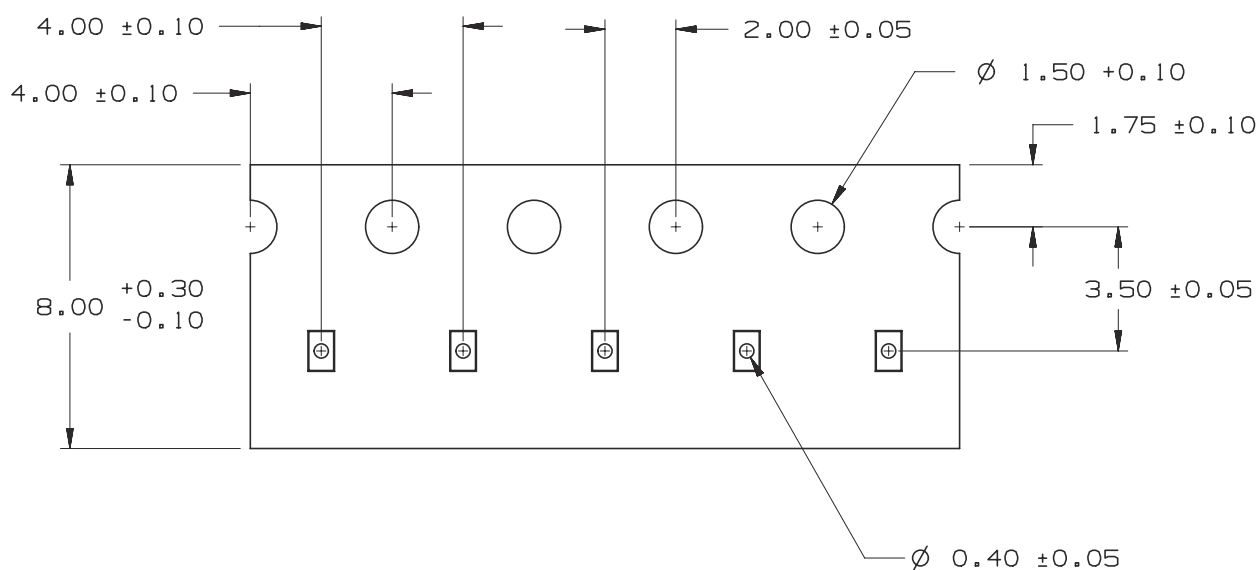
- A. All dimensions are in millimeters.
- B. For more information, see [FemtoFET Surface Mount Guide](#) (SLRA003D).

## 7.3 Recommended Stencil Pattern



- A. All dimensions are in millimeters.

## 7.4 CSD13381F4 Embossed Carrier Tape Dimensions



- A. Pin 1 is oriented in the top-right quadrant of the tape enclosure (quadrant 2), closest to the carrier tape sprocket holes.

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Other
CSD13381F4	ACTIVE	PICOSTAR	YJC	3	3000	RoHS & Green	NIAU	Level-1-260C-UNLIM	
CSD13381F4T	ACTIVE	PICOSTAR	YJC	3	250	RoHS & Green	NIAU	Level-1-260C-UNLIM	

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including but not limited to lead (Pb). All RoHS substances must not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free soldering processes. TI reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm. All other flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line of the previous line and the two combined represent the entire Device Marking for that device.

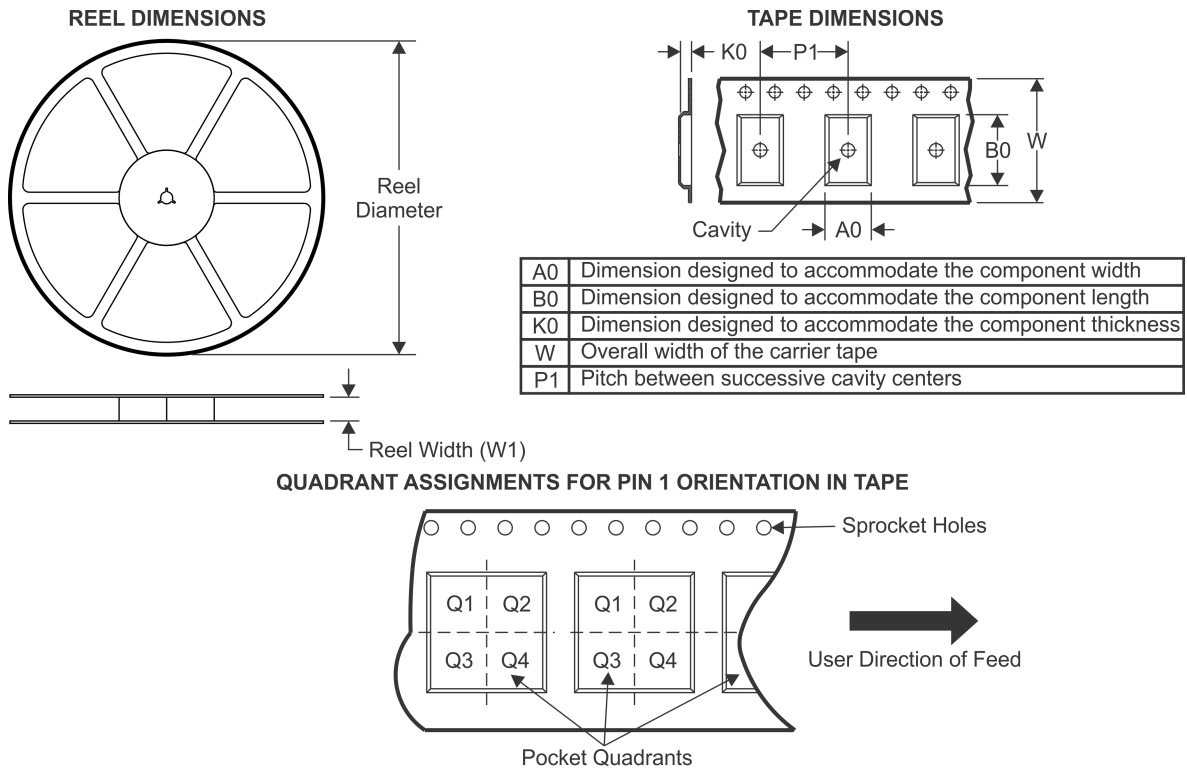
(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values are shown in columns separated by vertical ruled lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its information on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties into TI's data sheets. TI continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on all products or materials. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on the date of purchase.



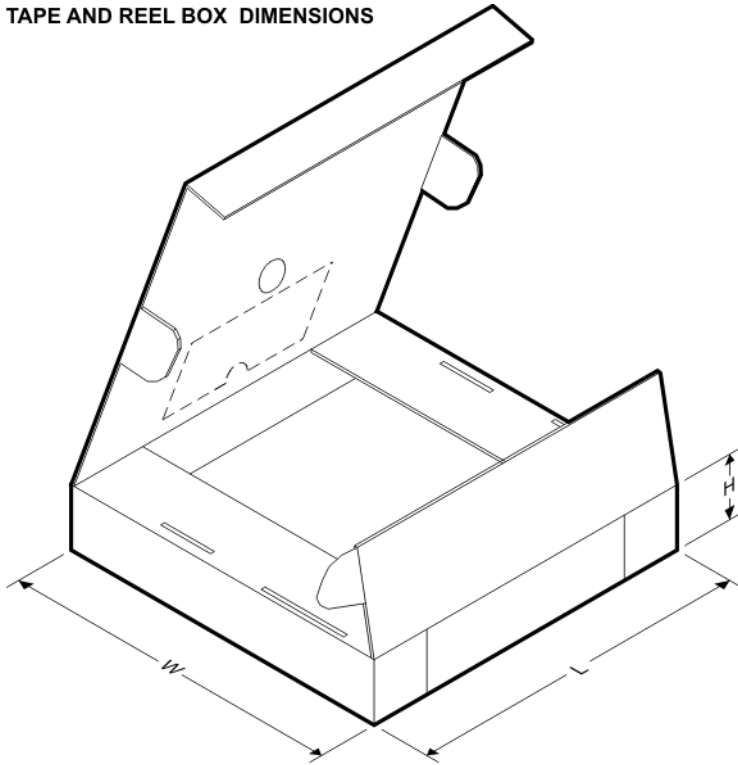
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD13381F4	PICOST AR	YJC	3	3000	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4	PICOST AR	YJC	3	3000	178.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4T	PICOST AR	YJC	3	250	178.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4T	PICOST AR	YJC	3	250	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD13381F4	PICOSTAR	YJC	3	3000	182.0	182.0	20.0
CSD13381F4	PICOSTAR	YJC	3	3000	220.0	220.0	35.0
CSD13381F4T	PICOSTAR	YJC	3	250	220.0	220.0	35.0
CSD13381F4T	PICOSTAR	YJC	3	250	182.0	182.0	20.0

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#) or other applicable terms available either on [ti.com](https://www.ti.com) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265  
Copyright © 2022, Texas Instruments Incorporated